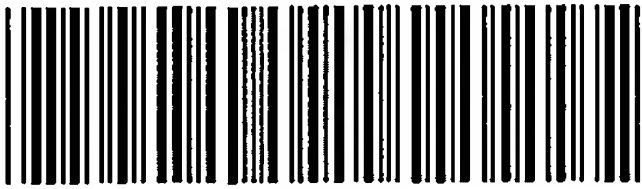


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent und r R examination	
	10/629,429	DEMIR, ALPASLAN	
	Examin r	Art Unit	
	Ted M. Wang	2611	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	6/1/2006	TW